

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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SPECIFICATION

(Reference sheet)

· Supplier : Samsung electro-mechanics · Samsung P/N : CL21C220JBANNNC

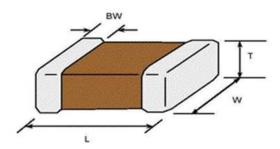
• Product : Multi-layer Ceramic Capacitor • Description : CAP, 22pF, 50V, ± 5%, C0G, 0805

A. Samsung Part Number

<u>CL</u> <u>21</u> <u>C</u> <u>220</u> <u>J</u> <u>B</u> <u>A</u> <u>N</u> <u>N</u> <u>N</u> <u>C</u> ① ② ③ ④ ⑤ ⑥ ⑦ ⑧ ⑨ ⑩ ⑪

① Series	Samsung Multi-layer Ceramic Capacitor				
② Size	0805 (inch code)	L: 2.00 ± 0.10 mm	W: 1.25 ± 0.10 mm		
③ Dielectric	COG	Inner electrode	Ni		
Capacitance	22 pF	Termination	Cu		
⑤ Capacitance	± 5%	Plating	Sn 100% (Pb Free)		
tolerance		Product	Normal		
6 Rated Voltage	9 50 V	Special	Reserved for future use		
7 Thickness	0.65 ± 0.10 mm	Packaging	Cardboard Type, 7" reel		

B. Structure and dimension



Samsung P/N	Dimension(mm)				
Samsung F/N	L	W	Т	BW	
CL21C220JBANNNC	2.00 ± 0.10	1.25 ± 0.10	0.65 ± 0.10	0.50+0.20/-0.30	

C. Samsung Reliability Test and Judgement condition

	Judgement	Test condition		
Capacitance	Within specified tolerance	1™z±10% / 0.5~5Vrms		
Q	840 min	7		
Insulation	10,000Mohm or 500Mohm x <i>μ</i> F	Rated Voltage 60~120 sec.		
Resistance	Whichever is smaller			
Appearance	No abnormal exterior appearance	Microscope (X10)		
Withstanding	No dielectric breakdown or	300% of the rated voltage		
Voltage	mechanical breakdown			
Temperature	COG			
Characteristics	(From -55 $^{\circ}$ C to 125 $^{\circ}$ C, Capacitance change should be within ±30PPM/ $^{\circ}$ C)			
Adhesive Strength	No peeling shall be occur on the 500g×F, for 10±1 sec.			
of Termination	terminal electrode			
Bending Strength	Capacitance change :	Bending to the limit (1mm)		
	within ±5% or ±0.5pF whichever is larger	with 1.0mm/sec.		
Solderability	More than 75% of terminal surface	SnAg3.0Cu0.5 solder		
	is to be soldered newly	245±5℃, 3±0.3sec.		
		(preheating : 80~120 ℃ for 10~30sec.)		
Resistance to	Capacitance change :	Solder pot : 270±5℃, 10±1sec.		
Soldering heat	within ±2.5% or ±0.25pF whichever is larger			
-	Tan δ, IR : initial spec.			
Vibration Test	Capacitance change :	Amplitude: 1.5mm		
	within ±2.5% or ±0.25pF whichever is larger	From 10Hz to 55Hz (return : 1min.)		
	Tan δ, IR : initial spec.	2hours ´ 3 direction (x, y, z)		
Moisture	Capacitance change :	With rated voltage		
Resistance	within ±7.5% or ±0.75pF whichever is larger	40±2℃, 90~95%RH, 500+12/-0hrs		
	Q: 173.33 min			
	IR: 500Mohm or 25Mohm × μ F			
	Whichever is smaller			
High Temperature	Capacitance change :	With 200% of the rated voltage		
Resistance	within ±3% or ±0.3pF whichever is larger	Max. operating temperature		
	Q: 330.00 min	1,000+48/-0hrs		
	IR: 1,000Mohm or 50Mohm × μ F			
	Whichever is smaller			
Temperature	Capacitance change :	1 cycle condition		
Cycling	within ±2.5% or ±0.25pF whichever is larger	Min. operating temperature \rightarrow 25°C		
, ,	Tan δ, IR : initial spec.	→ Max. operating temperature → 25°C		
		5 cycle test		

^{*} The reliability test condition can be replaced by the corresponding accelerated test condition.

D. Recommended Soldering method:

Reflow (Reflow Peak Temperature : 260±5 ℃, 30sec.)



A Product specifications included in the specifications are effective as of March 1, 2013.

Please be advised that they are standard product specifications for reference only.

We may change, modify or discontinue the product specifications without notice at any time.

So, you need to approve the product specifications before placing an order.

Should you have any question regarding the product specifications,

please contact our sales personnel or application engineers.

Disclaimer & Limitation of Use and Application

The products listed in this Specification sheet are **NOT** designed and manufactured for any use and applications set forth below.

Please note that any misuse of the products deviating from products specifications or information provided in this Spec sheet may cause serious property damages or personal injury.

We will **NOT** be liable for any damages resulting from any misuse of the products, specifically including using the products for high reliability applications as listed below.

If you have any questions regarding this 'Limitation of Use and Application', you should first contact our sales personnel or application engineers.

- ① Aerospace/Aviation equipment
- 2 Automotive or Transportation equipment (vehicles, trains, ships, etc)
- 3 Medical equipment
- 4 Military equipment
- ⑤ Disaster prevention/crime prevention equipment
- 6 Power plant control equipment
- Atomic energy-related equipment
- Undersea equipment
- Traffic signal equipment
- Data-processing equipment
- ## Electric heating apparatus, burning equipment
- Safety equipment
- ® Any other applications with the same as or similar complexity or reliability to the applications